

**The RF Line**  
**UHF Power Transistors**

The TP3019 and TP3019S are designed for 24 V common emitter base station amplifiers. Operating in the 820-960 MHz bandwidth, they have been specifically designed for use in analog and digital (GSM) systems. The studless package version offers a good possibility for surface mounting.

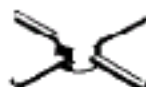
- Specified 24 Volts, 960 MHz Characteristics
  - Output Power = 2.0 Watts
  - Minimum Gain = 9.0 dB
  - Class AB
  - $I_Q = 20$  mA

**TP3019**  
**TP3019S**

**2.0 W-960 MHz**  
**UHF POWER**  
**TRANSISTORS**  
**NPN SILICON**



CASE 305A-01, STYLE 1  
 TP3019S



CASE 305-01, STYLE 1  
 TP3019

**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	$V_{CER}$	40	Vdc
Collector-Base Voltage	$V_{CBO}$	50	Vdc
Emitter-Base Voltage	$V_{EBO}$	4.0	Vdc
Collector-Current — Continuous	$I_C$	1.0	Adc
Total Device Dissipation <sup>m</sup> $T_C = 25$ C Derate above 25 C	$P_D$	12.5 0.15	Watts W/C
Storage Temperature Range	$T_{stg}$	65 to -150	C
Operating Junction Temperature	$T_J$	200	C

**THERMAL CHARACTERISTICS**

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case (1) at 70 C Case	$R_{\theta JC}$	14	C/W

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25$  C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

**OFF CHARACTERISTICS**

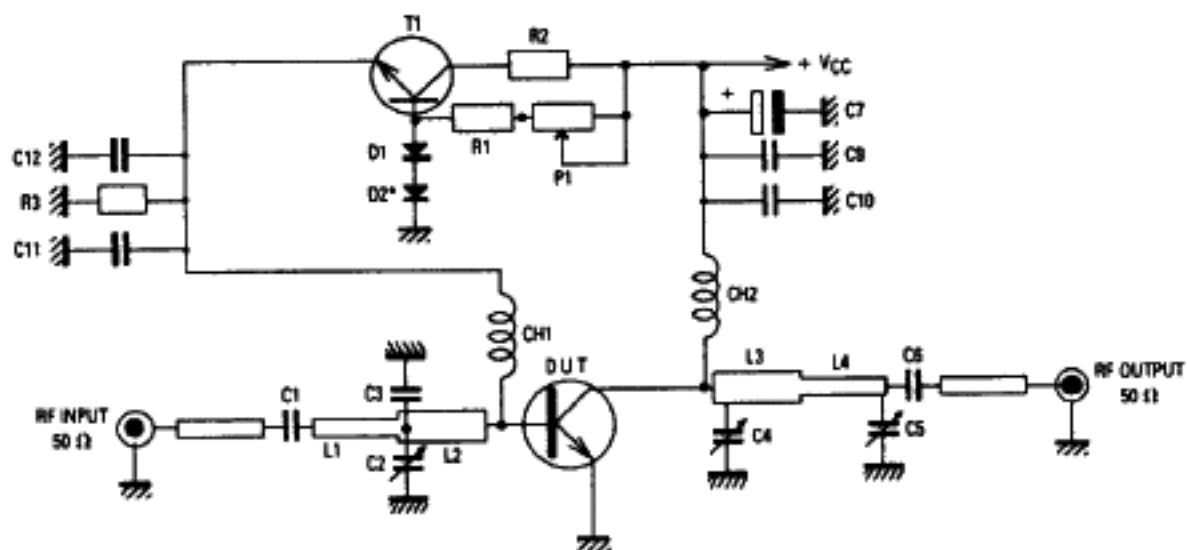
Collector-Emitter Breakdown Voltage ( $I_C = 5.0$ mA, $I_B = 0$ )	$V_{(BR)CER}$	28	—	—	Vdc
Emitter-Base Breakdown Voltage ( $I_C = 1.0$ mA)	$V_{(BR)EBO}$	3.5	—	—	Vdc
Collector-Base Breakdown Voltage ( $I_E = 5.0$ mA)	$V_{(BR)CBO}$	50	—	—	Vdc
Collector-Emitter Leakage ( $V_{CE} = 20$ V)	$I_{CES}$	—	—	2.0	mA

NOTE 1 Thermal resistance is determined under specified RF operating condition

(continued)

**ELECTRICAL CHARACTERISTICS — continued** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit*
<b>ON CHARACTERISTICS</b>					
DC Current Gain ( $I_C = 1.0 \text{ A dc}, V_{CE} = 5.0 \text{ V dc}$ )	$h_{FE}$	15	—	150	—
<b>DYNAMIC CHARACTERISTICS</b>					
Output Capacitance ( $V_{CB} = 25 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$ )	$C_{ob}$	—	—	4.0	pF
<b>FUNCTIONAL TESTS</b>					
Common-Emitter Amplifier Power Gain ( $V_{CC} = 24 \text{ V}, P_{out} = 2.0 \text{ W}, I_{CQ} = 20 \text{ mA}$ ) ( $f = 960 \text{ MHz}$ )	$G_p$	9.0	—	—	dB
Load Mismatch at all Phase Angles ( $V_{CC} = 24 \text{ V}, P_{out} = 2.0 \text{ W}, I_{CQ} = 20 \text{ mA}$ ) No degradation in Output Power	$\psi$	20:1	—	—	VSWR
Collector Efficiency ( $V_{CC} = 24 \text{ V}, P_{out} = 2.0 \text{ W}, f = 960 \text{ MHz}$ )	$\eta_c$	50	55	—	%



\*Contact with RF Transistor

- C2, C4, C5 — Trimmer Capacitor 0.5–4.0 pF
- C1, C6, C10, C11 — Capacitor Chip 0805 330 pF 5%
- C9, C12 — Capacitor Chip 0805 15 nF 5%
- C3 — Capacitor Chip 0805 3.9 pF 5%
- C7 — Capacitor Chip 0805 6.0, 8.0  $\mu\text{F}$  35 V
- R1 — Resistor 1.0 k $\Omega$  5%
- L1 — Microstrip Line 50  $\Omega$  L = 12 mm
- L2 — Microstrip Line 25  $\Omega$  L = 6 mm

- R2 — Resistor 100  $\Omega$  2.0 W
- R3 — Chip Resistor 75  $\Omega$  0805 5%
- P1 — Trimmer 5.0 k $\Omega$
- T1 — Transistor BD135 or Similar
- CH1 — Microstrip Line 80  $\Omega$  L = 23 mm
- CH2 — 3 Turns Wire 8/10 ID 4 mm
- D1, D2 — Diode 1N4148
- L3 — Microstrip Line 25  $\Omega$  L = 6 mm
- L4 — Microstrip Line 50  $\Omega$  L = 28 mm
- Board Material — 1 50', Teflon Glass, Cu Clad 2 Sides, 35  $\mu\text{m}$  Thick

Figure 1. 960 MHz Test Circuit

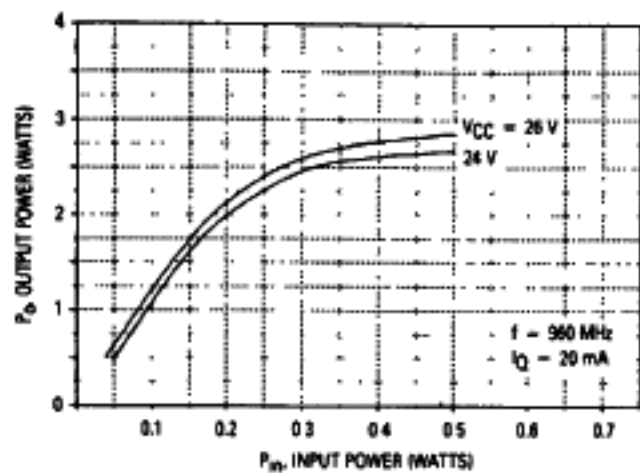
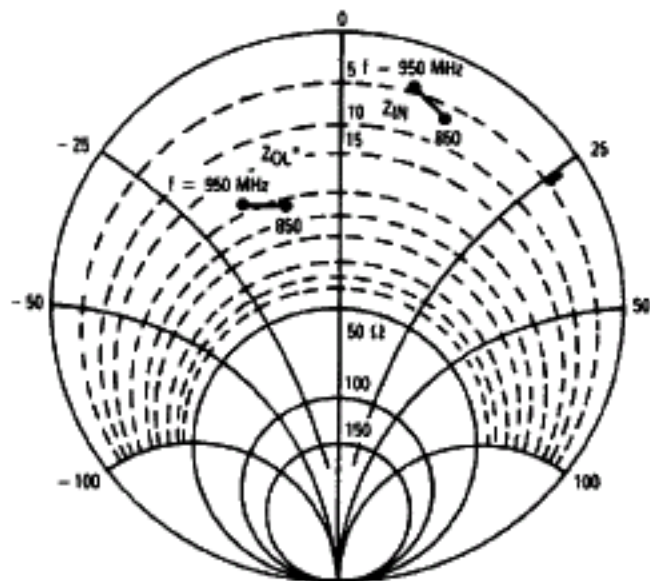


Figure 2. Output Power versus Input Power



$P_{Out} = 2\text{ W}$   $V_{CE} = 24\text{ V}$

$f$ MHz	$Z_{IN}$ OHMS	$Z_{OL}^*$ OHMS
850	$5.8 + j9.8$	$21.3 - j10$
900	$5.4 + j9$	$21 - j11$
950	$4.8 + j7.9$	$20 - j14$

$Z_{OL}^*$  = Conjugate of the optimum load impedance into which the device operates at a given output power, voltage, and frequency

Figure 3. Series Equivalent Input/Output Impedances

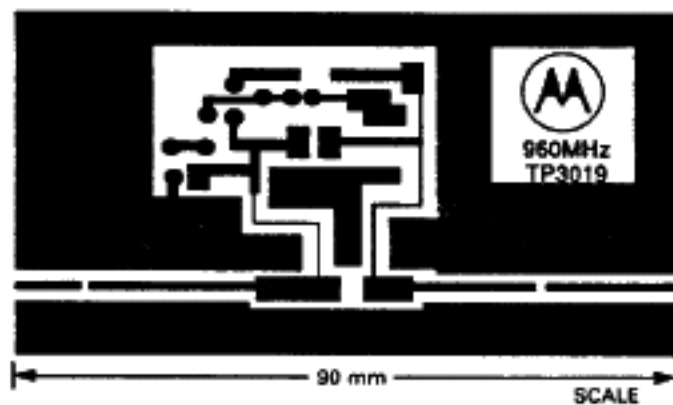


Figure 4. Test Circuit — Photomaster

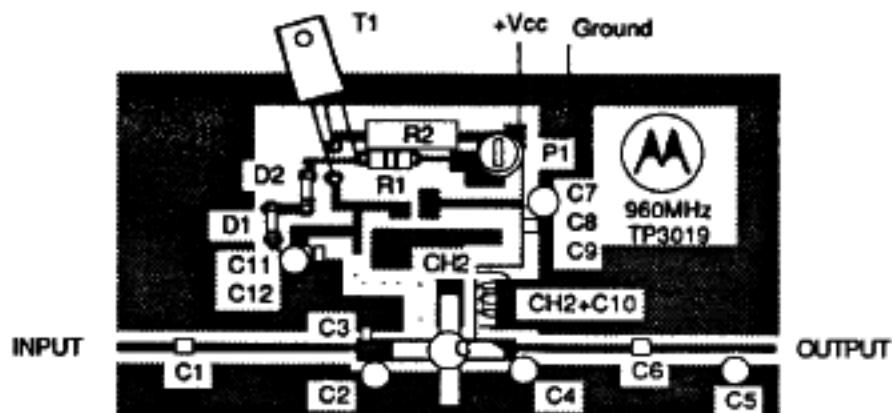


Figure 5. Test Circuit — Component Locations